

October 1995 Revised February 2002

## 74LCX38

# Low Voltage Quad 2-Input NAND Gate (Open Drain) with 5V Tolerant Inputs

## **General Description**

The LCX38 contains four 2-input open drain NAND gates. The inputs tolerate voltages up to 7V allowing the interface of 5V systems to 3V systems.

The 74LCX38 is fabricated with advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

#### **Features**

- 5V tolerant inputs
- 2.3V to 3.6V V<sub>CC</sub> specifications provided
- 5.0 ns  $t_{PD}$  max ( $V_{CC} = 3.3V$ ), 10  $\mu$ A  $I_{CC}$  max
- Power down high impedance inputs and outputs
- 24 mA output drive (V<sub>CC</sub> = 3.0V)
- Implements patented noise/EMI reduction circuitry
- Latch-up performance exceeds 500 mA
- ESD performance:

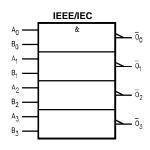
Human body model > 2000V Machine model > 150V

## **Ordering Code:**

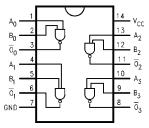
Order Number	Package Number	Package Description
74LCX38M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74LCX38SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74LCX38MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### **Logic Symbol**



## **Connection Diagram**



## **Pin Descriptions**

Pin Names	Description
A <sub>n</sub> , B <sub>n</sub>	Inputs
$\overline{O}_n$	Outputs

## Absolute Maximum Ratings(Note 1)

Symbol	Parameter	Value	Conditions	Units
V <sub>CC</sub>	Supply Voltage	-0.5 to +7.0		V
VI	DC Input Voltage	-0.5 to +7.0		V
Vo	DC Output Voltage	-0.5 to +7.0	Output in HIGH or LOW State (Note 2)	V
I <sub>IK</sub>	DC Input Diode Current	-50	V <sub>I</sub> < GND	mA
I <sub>OK</sub>	DC Output Diode Current	-50	V <sub>O</sub> < GND	mA
Io	DC Output Sink Current (I <sub>OL</sub> )	+50		mA
I <sub>CC</sub>	DC Supply Current per Supply Pin	±100		mA
I <sub>GND</sub>	DC Ground Current per Ground Pin	±100		mA
T <sub>STG</sub>	Storage Temperature	-65 to +150		°C

## **Recommended Operating Conditions** (Note 3)

Symbol	Parameter	Min	Max	Units
V <sub>CC</sub>	Supply Voltage Operating	g 2.0	3.6	
	Data Retention	n 1.5	3.6	V
V <sub>I</sub>	Input Voltage	0	5.5	V
Vo	Output Voltage	0	5.5	V
I <sub>OL</sub>	Output Current $V_{CC} = 3.0V - 3.6$	<b>V</b>	24	
	Output Current $V_{CC} = 3.0V - 3.6$ $V_{CC} = 2.7V - 3.0$ $V_{CC} = 2.3V - 2.7$	<b>V</b>	12	mA
	$V_{CC} = 2.3V - 2.7$	<b>V</b>	8	
T <sub>A</sub>	Free-Air Operating Temperature	-40	85	°C
Δt/ΔV	Input Edge Rate, $V_{IN} = 0.8V-2.0V$ , $V_{CC} = 3.0V$	0	10	ns/V

Note 1: The Absolute Maximum Ratings are those beyond which the safety of the device cannot be guaranteed. The device should not be operating at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2:  $I_O$  Absolute Maximum Rating must be observed.

Note 3: Unused inputs must be held HIGH or LOW. They may not float.

### **DC Electrical Characteristics**

Symbol	Parameter	Conditions	V <sub>CC</sub>	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$		Units
Symbol		Conditions	(V)	(V) Min M		Onito
V <sub>IH</sub>	HIGH Level Input Voltage		2.3 – 2.7	1.7		V
			2.7 – 3.6	2.0		V
V <sub>IL</sub>	LOW Level Input Voltage		2.3 – 2.7		0.7	V
			2.3 – 3.6		0.8	V
V <sub>OL</sub>	LOW Level Output Voltage	I <sub>OL</sub> = 100μA	2.3 – 3.6		0.2	
		I <sub>OL</sub> = 8mA	2.3		0.6	
		I <sub>OL</sub> = 12 mA	2.7		0.4	V
		I <sub>OL</sub> = 16 mA	3.0		0.4	
		I <sub>OL</sub> = 24 mA	3.0		0.55	
I <sub>I</sub>	Input Leakage Current	0 ≤ V <sub>I</sub> ≤ 5.5V	2.3 – 3.6		±5.0	μΑ
l <sub>OFF</sub>	Power-Off Leakage Current	$V_I$ or $V_O = 5.5V$	0		10	μА
I <sub>CC</sub>	Quiescent Supply Current	$V_I = V_{CC}$ or GND	2.3 – 3.6		10	
		$3.6V \le V_1 \le 5.5V$	2.3 – 3.6		±10	μΑ
$\Delta I_{CC}$	Increase in I <sub>CC</sub> per Input	$V_{IH} = V_{CC} - 0.6V$	2.3 – 3.6		500	μА
I <sub>OHZ</sub>	Off State Current	V <sub>O</sub> = 5.5	2 - 3.6		10	μΑ

## **AC Electrical Characteristics**

	Parameter	$T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$ , $R_L = 500~\Omega$						
Symbol		$V_{CC} = 3.3V \pm 0.3V$ $C_L = 50 \text{ pF}$		V <sub>CC</sub> = 2.7V C <sub>L</sub> = 50 pF		$V_{CC} = 2.5V \pm 0.2V$ $C_L = 30 \text{ pF}$		Units
Symbol								
		Min	Max	Min	Max	Min	Max	
t <sub>PZL</sub>	Propagation Delay Time	1.5	5.0	1.5	5.5	1.5	6.5	no
t <sub>PLZ</sub>		1.5	5.0	1.5	5.5	1.5	6.0	ns
t <sub>OSHL</sub>	Output to Output Skew		1.0					ns
toslh	(Note 4)		1.0					113

Note 4: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t<sub>OSHL</sub>) or LOW-to-HIGH (t<sub>OSLH</sub>).

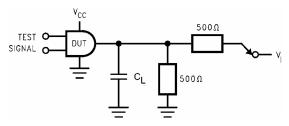
## **Dynamic Switching Characteristics**

Symbol	Parameter	Conditions	v <sub>cc</sub>	$T_A = 25^{\circ}C$	Units
			(V)	Typical	
V <sub>OLP</sub>	Quiet Output Dynamic Peak V <sub>OL</sub>	$C_L = 50 \text{ pF, } V_{IH} = 3.3 \text{V, } V_{IL} = 0 \text{V}$	3.3	0.8	V
		$C_L = 30 \text{ pF, } V_{IH} = 2.5 \text{V, } V_{IL} = 0 \text{V}$	2.5	0.6	V
V <sub>OLV</sub>	Quiet Output Dynamic Valley V <sub>OL</sub>	$C_L = 50 \text{ pF, } V_{IH} = 3.3 \text{V, } V_{IL} = 0 \text{V}$	3.3	-0.8	V
		$C_L = 30 \text{ pF}, V_{IH} = 2.5 \text{V}, V_{IL} = 0 \text{V}$	2.5	-0.6	V

# Capacitance

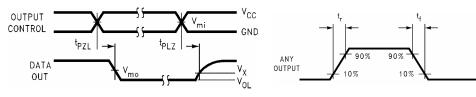
Symbol	Parameter	Conditions	Typical	Units
C <sub>IN</sub>	Input Capacitance	$V_{CC} = Open, V_I = 0V \text{ or } V_{CC}$	7	pF
C <sub>OUT</sub>	Output Capacitance	$V_{CC} = 3.3V$ , $V_I = 0V$ or $V_{CC}$	8	pF
C <sub>PD</sub>	Power Dissipation Capacitance	$V_{CC} = 3.3V$ , $V_{I} = 0V$ or $V_{CC}$ , $f = 10$ MHz	25	pF

# AC Loading and Waveforms Generic for LCX Family



 $\label{eq:FIGURE 1. AC Test Circuit} \mbox{($C_L$ includes probe and jig capacitance)}$ 

Test	Switch
t <sub>PZL</sub> , t <sub>PLZ</sub>	6V at $V_{CC} = 3.3 \pm 0.3V$ $V_{CC} \times 2$ at $V_{CC} = 2.5 \pm 0.2V$

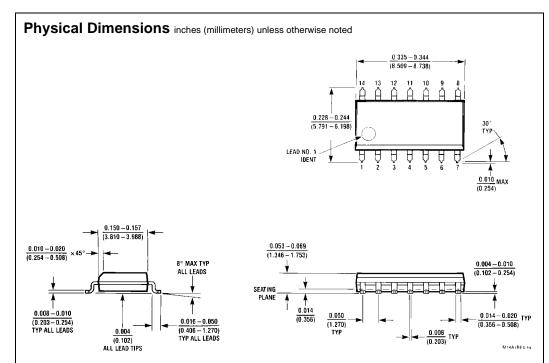


3-STATE Output Low Enable and Disable Times for Logic

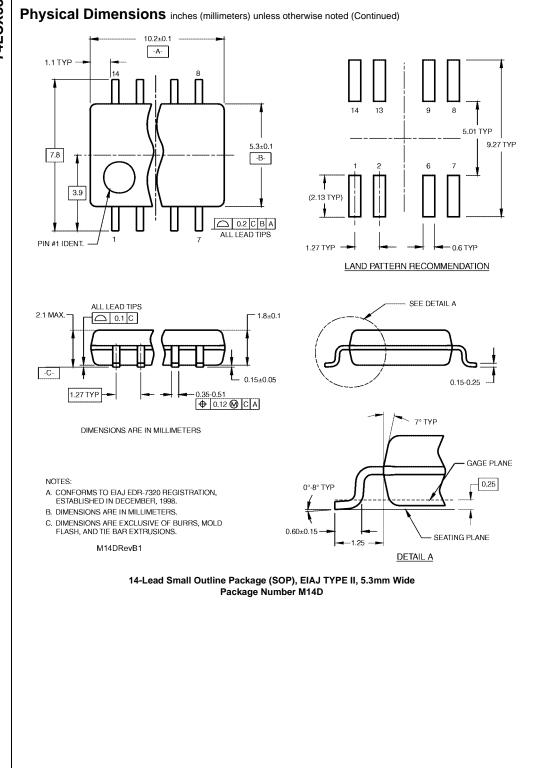
 $t_{rise}$  and  $t_{fall}$ 

 $\label{eq:figure 2} \mbox{Figure 2. Waveforms} \\ \mbox{(Input Pulse Characteristics; f = 1MHz, $t_r = t_f = 3ns$)} \\$ 

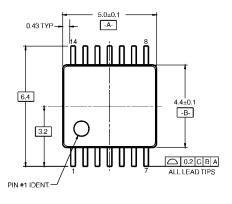
Symbol	V <sub>CC</sub>				
- Cynnbon	3.3V ± 0.3V	2.7V	2.5V ± 0.2V		
V <sub>mi</sub>	1.5V	1.5V	V <sub>CC</sub> /2		
V <sub>mo</sub>	1.5V	1.5V	V <sub>CC</sub> /2		
V <sub>x</sub>	V <sub>OL</sub> + 0.3V	V <sub>OL</sub> + 0.3V	V <sub>OL</sub> + 0.15V		
V <sub>y</sub>	V <sub>OH</sub> – 0.3V	V <sub>OH</sub> – 0.3V	V <sub>OH</sub> – 0.15V		

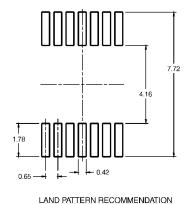


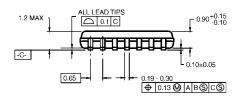
14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M14A

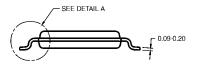


## Physical Dimensions inches (millimeters) unless otherwise noted (Continued)





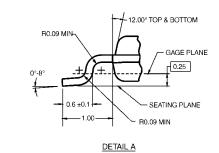




NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6, DATE 7/93.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

MTC14RevC3



14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC14

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